

Search Notes



Application/Control No.

10/673,639

Examiner

José V. Chen

Applicant(s)/Patent under Reexamination

MASSEY ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
52	204.1	3/25/06	JLC
	717.01		
	717.02		
49	467		
	469		
	471		
	504		
	505		
		4/12/07	JLC
52	204.51		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
52	204.1	4/12/07	JLC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
SEARCH FE SACK IN 52	3/27/06	JLC
SEARCH FE SACK IN 49		
UPDATED	4/12/07	JLC
TEXT SEARCH TEST Discussed w/ Examiner		